

Status of FPIX Production

A.Hahn



Outline

- Flow Chart of Detector Assembly
- Detector Assembly Status
 - VHDI
 - Plaquette/Panel Testing
 - Panels
 - Half-Disk Assembly
 - Final Assembly
- Summary



Flow Chart of Production Assembly

Plaquette Production

VHDI Lamination on silicon Populate VHDI with capacitors Dice VHDI sheet

Probe testing of VHDI
(@KSU)

Build Plaquette from Bump-Bonded Sensors/ROC, &VHDI) & Quick Test (WBS 5.3.1--Purdue)

Burn-in of Plaquette

Plaquette Qualification Test

Panel Production

HDI Lamination onto Be

Probe testing of HDI

Populate with capacitors Install wires, TBM etc "Bare Panel"

Burn-in TBM& Panel

Install Plaquettes on Panel

Wire Bond Plaquettes

Panel Qualification Test

We are up to here with production parts

Final Detector Assembly

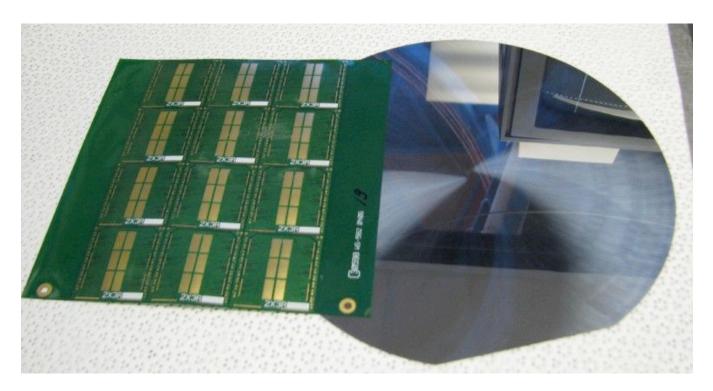
Assemble Cooling Channels into Half-Disks

Mount Panels on Half-Disks

Mount Half-Disks & Electronics on 1/2 Service Cylinder



VHDI Production



- •Flex circuit laminated to 300 μ Si Wafer with 3M9882 (50 μ thick) Thermally Conductive Adhesive Tape
- Probe Tested at KSU for electrical faults
- •We were working out Lamination Issues at time of last PMG
 - Now solved



VHDI Production Status

							rtemaning		
		Needed			Total KSU	KSU Test	Shipped to be	%tested/ship	
VHDI Ttype	Shipped to KSU	(25%spare)	KSU Good	KSU Bad	Tested	Yields	tested	ped	
1x2L	63	60	60	1	61	0.98	2	0.97	
1x2R	87	60	72	8	80	0.90	7	0.92	
1x5L	57	60	53	4	57	0.93	0	1.00	
1x5R	79	60	74	2	76	0.97	3	0.96	
2x3	310	240	167	23	190	0.88	120	0.61	
2x4	287	240	187	21	208	0.90	79	0.72	
2x5	182	120	114	10	124	0.92	58	0.68	
Plaquette Total	1065	840	727	69	796		269	0.75	
ROC Equivalent	6956	5400	4537	454	4991		1965	0.72	

last updated 9/25/06

•Using KSU Probe Testing Yields, we will need to order a few more sheets of VHDI's to cover our spare plaquette needs.

•ok for now

Remaining



Production Plaquette Testing

(FNAL, NU, UNL, UVa, Purdue-Calumet, SUNY-Buffalo)

- Plaquettes arrive from Purdue
 - Where they have already passed a quick functionality test
 - We make a"Very Quick Test" as they are unpacked at SiDet
- Immediately loaded into Burn-In Test
 - Temperature is cycled a 10 times between 20°C and -15°C over 2 day period
 - Modest testing
 - Multiplex through all 20 plaquettes, simply counting ultrablacks, perhaps an occasional pixel-alive test.
 - Will note time if a plaquette fails
- All plaquettes which have not obviously failed during the burn-in then undergo a Full Plaquette Characterization Test (slide after next)



Plaquette Testing- Burn-In Box

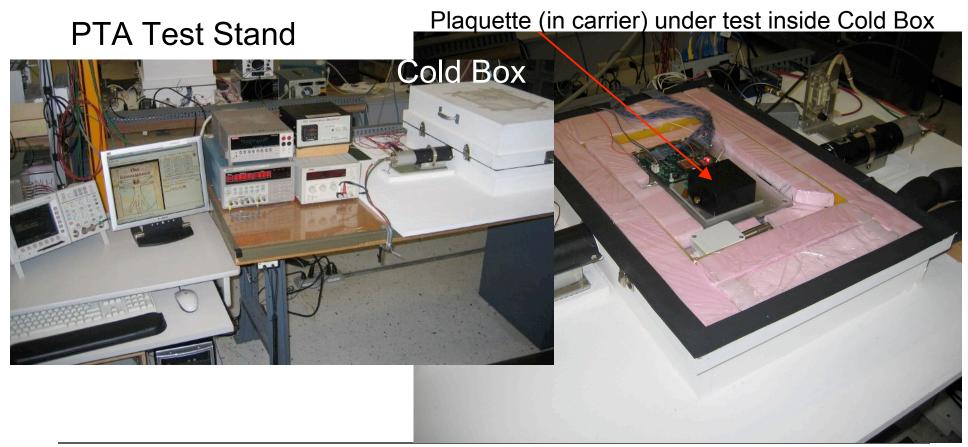


- •Each shelf can hold:
 - •2 Plaquette Carriers for 20 in total
 - •1 Panel carrier
 - for 10 Panels in total
 - Current Setup
 - •7 Plaquette, 3 Panel Shelves
- •10 Temp cycles between ~20<->-15°C
 - •2 day period
 - •LV and HV on
 - Modest testing runs continuously
- Currently in production
 - >160 plaquettes have been processed
 - No plaquette has yet failed during the burn-in
- •Weekly rate (3 runs) 42 Plaquettes, 9 Panels



Plaquette/Panel Testing

- •2 test Stations for Plaquettes (8 Plaquettes/day)
- •1 test Station for Panels (2 Full Panels/Day)
- Easily handles full Purdue Production rate (6 Plaquettes/day)





Production Plaquette Testing Plan

- Full Plaquette Characterization Tests at -15° C
 - Test Assumptions:
 - Want to verify that Plaquette works acceptably for mounting onto Panel
 - Do not need to provide final calibration of threshold trimming, Pixel Charge, or address levels
 - Assume calibration will be handled downstream by Calibration Group
- Plaquette Grading Scheme
 - "A": basically a "perfect" plaquette which is qualified to be mounted on a panel
 - "B": a plaquette with minor issues
 - >0.5% bad pixels in a single ROC (primarily bad bumps) ("B+" to "A-")
 - DAC settings $>4\sigma$ of mean of all plaquettes
 - A "B" plaquette may be mounted on a panel after more deliberations
 - e.g. if only one ROC fails the bad pixel levels
 - "C": a plaquette with major issues that will not be mounted on a panel
 - e.g. a completely dead ROC or massive #'s of bad bumps, or other issues

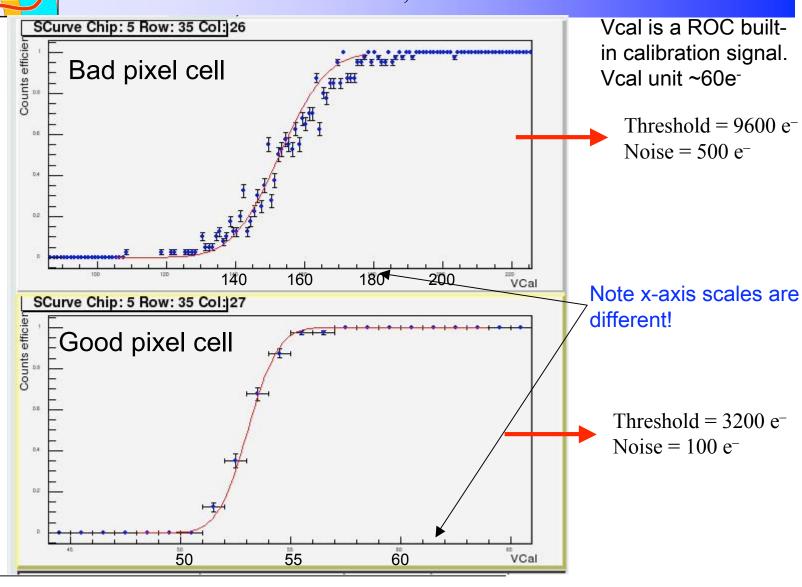


First 160 Production Plaquette Test Results

- 76 "A" (29 IZM, 47 RTI)
- 46 "B" (20 IZM, 26 RTI)
 - 8 have pixel "issues" <0.5% ("A-") (all RTI)
 - 7 have pixel "issues" <1.0% or slightly marginal HV ("B+") (4RTI, 3 IZM)
 - 18 have pixel "issues" < 2.5% ("B") (7RTI, 11 IZM)
 - 6 have total pixel "issues" <5% ("B-") (2 RTI, 4 IZM)
 - 7 have "more" marginal HV--need further discussion (4 RTI, 3 IZM)
- 38 "C" (32 IZM, 6RTI)
 - 27 of the 38 "C" graded plaquettes are due to a bad IZM processing step
 - Problem exhibited by low gains/high noise in many pixels in specific ROCS
 - Noticed these ROCs were came from the same geographic region of the wafer.
 - Verified effect with movable pulse Laser aimed into Sensor cells
 - 5 have breakdown issues (3 RTI, 2 IZM)
 - 2 have hundreds missing bumps (all RTI)
 - Remainder are miscellaneous problems in ROC's
- B grades are currently under active discussions!
 - RTI pixel issues are all missing bumps
 - IZM pixel Issues are IZM effect.

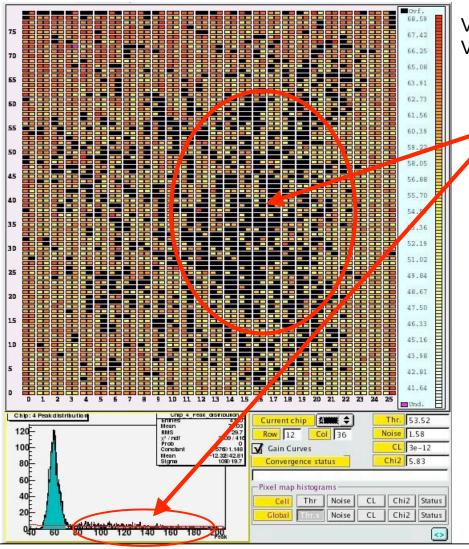


"IZM Effect": Comparison of a good and bad cell of chip5. Fix threshold, scan Vcal





Threshold dispersion of chip4, Fix Common Threshold @~50 Vcal units for entire chip, scan Vcal



Vcal is a ROC built-in calibration signal. Vcal unit ~60e⁻

Black Pixel = very high threshold

It is clearly evident the region of the ROC were the threshold of the pixels is much higher.

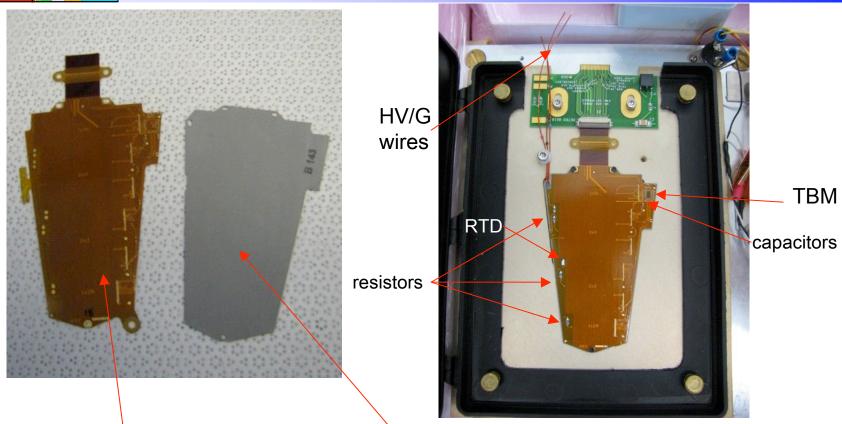


Plaquettes Summary

- We have alerted IZM to this problem and they are looking how to avoid the problem in the future.
 - Manufacturer is trying to rework a few selected plaquettes with that had only one of these ROCs.
- RTI has some issues with missing bump-bonds
 - Also working with them to improve quality
- IF all the "A" & "B" grade categories are usable
 - 15 blades worth of panels (2 panels/blade)
 - Roughly equal # of left and right given by 1xN L&R numbers.
 - One Half Disk needs 12 blades worth of panels
- However the "B"'s are still under group discussion



"Bare" Panel Production



"Bare" 4R_{ight} Panel on Panel carrier

- Flex Circuit laminated to 500μ thick Be plate with 3M9882 (50 μ thick) Thermally Conductive Adhesive Tape
- Bare Panel = Populated (resistors, capacitors, RTD), Wires soldered, TBM attached, and wirebonded



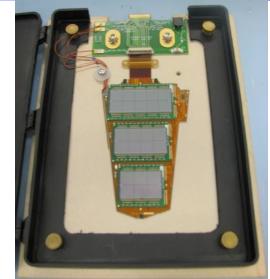
Bare Panel Yields

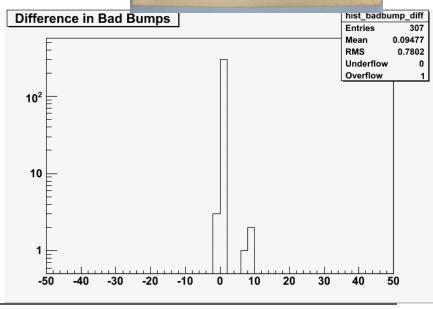
	4R	3R
Manufacturer Defects	20	7
Production failures	9	14
Test&2007 Detector	4	5
Production	37	44
Sum	70	70
Needed for full Production/Spare	55	55
deficit	18	11



Full Panel Production Inventory

- Eight 2007 Pilot Run Panels
 - Plaquettes taken (primarily) from preproduction plaquettes
 - Four 3R and four 4R types
- Full Production Panels
 - Six good 3R Panels
 - (one damaged during production)
 - Seven good 4R Panels
 - We pick up a few more bad bumps on the RTI plaquettes after panel building
 - These are typically in corners of plaquettes which already had some bad bumps



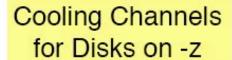




Assemble and leak test HalfDisk Parts









Need 8



½-Disk





Need 2



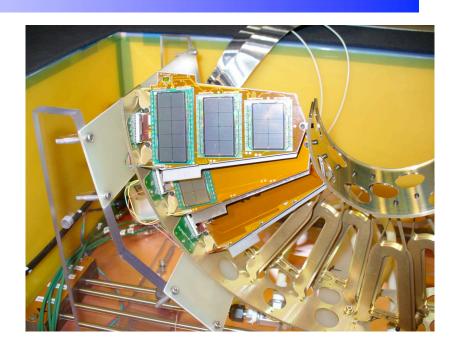
17

Nipples



Mount and Test Panels on Half-Disk Assembly

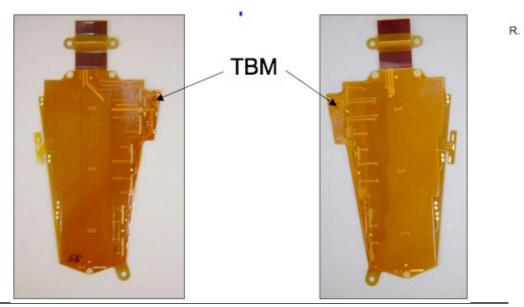
- Mechanics (-Z HD) should be ready end of October for first Half-Disk
- Need 24 panels
 - Currently
 - At least two 3L and two 4L Panels
 - Left HDI availability?
 - Four more 3(L or R) and three more 4(L or R) panels
 - Plaquettes to put on

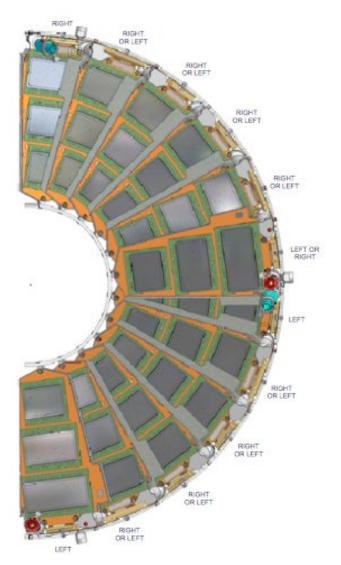




Panel Production Schedule Implications

- Panels needed for first Half Disks ("-Z")
 - See Doc 583 G. Derylo
 - Must have <u>at least</u> two 3L, two
 4L panels, one 3R, and one 4R
 - Remainder can be either R or L







2007 Pilot Run HalfDisk Assembly

- •2007 Pilot Run Panels are ready (8 total)
- •All are now mounted onto the two 2007 Half-Disks
 - Cooling and electrical tests underway
- < 2 hrs to mount 4 panels on 2nd Half-Disk
 - •~1 day to mount 24 panels on Production Detector
- •Plan for Pilot run Detector to be completed end of November 06 and shipped to Tracker Integration Facility at CERN





20



Mount support electronics and half Disks into 1/2 Service Cylinder

•2007 Pilot Run Detector Half-Disk Mechanics





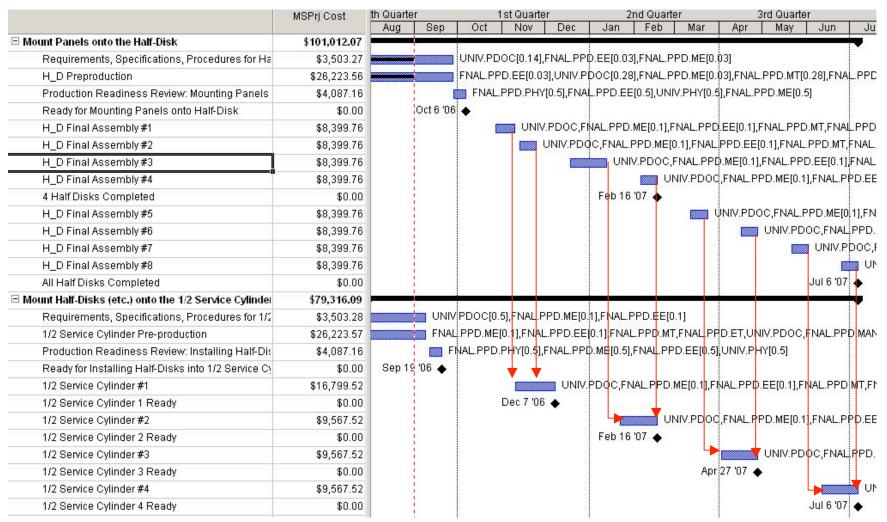


Final Detector Assembly

- Final detector assembly in Lab C at SiDET.
 - Assembling cooling channels into Half-Disks
 - First production finished end of October 06
 - Placing panels on Half-Disks
 - Quick functionality tests
 - Mounting support electronics and cooling into 1/2 service cylinders.
 - Mount Half Disks into 1/2 Service Cylinder #1
 - ~early December 06-January 07
 - Commissioning @ SiDET
 - Shipping to CERN (TIF) end Jan 07
 - Will ship remaining three 1/2 service cylinders @ one every 2 months



Final Assembly Schedule (from Aug.06)



Gaps are set by Plaquette Production rates and scheduling (wait to make panels until all plaquettes for that panel's HD are tested). This gives some more schedule float.



Summary

- All Production steps thru Panel Testing have begun and produced parts.
 - Issues with bump bonding have been identified and manufacturers alerted to problem.
 - QC of production line needs vigilence
- Pilot 2007 Detector Panels have been Mounted on Half-Disks
- Expect production panel mounting onto HD late October 06
- First Half-Disk assembly with panels Nov 06
 - Roughly produce one Half-Disk/month (8 total)
- First Production Complete 1/2 Service Cylinder shipped to TIF in late Jan 07.



Summary- ManPower Issues

- We are now peaking in manpower as the production pipeline is filled
 - People have all been identified and are on board
 - Main effort (engineers and senior techs) occurs at beginning of each new step as we solve initial setup problems
 - Production manpower needs are beginning to wind down
 - Labor intensive work (VHDI/HDI laminations, visual inspections.....) are coming to an end in the next few months
 - (some redo's)
 - Final assembly is with fewer number of parts
 - 672 Plaquettes->192 Panels->8 Half-Disks->4 Half-Cylinders
- Most testing is done with University and FNAL Physicists.